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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/045,055	BENOUDIZ, EYAL	
Examiner	Art Unit	
Chuck Kendall	2192	

·	SEARCHED		
Class	Subclass	Date	Examiner
717	124-135	6/16/2005 ²	СК
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INTERFERENCE SEARCHED			
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SEARCH NOT (INCLUDING SEARCH :)
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East Search (USPAT,USPGPUB,IBM,DERWENT,J PO,EPO)	6/16/2005	СК
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